

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): CHENG et al

Serial No.:

Filed: July 17, 2003

For: Inspection Method And Apparatus For Circuit Pattern

Group:

Examiner:

**PRELIMINARY AMENDMENT**

Mail Stop: Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

July 17, 2003

Sir:

The following preliminary amendments and remarks are respectfully  
submitted in connection with the above-identified application.